

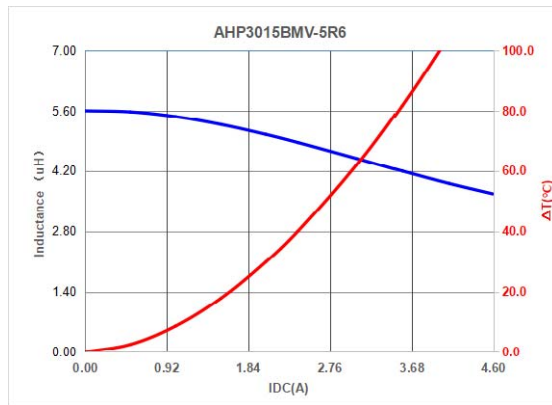
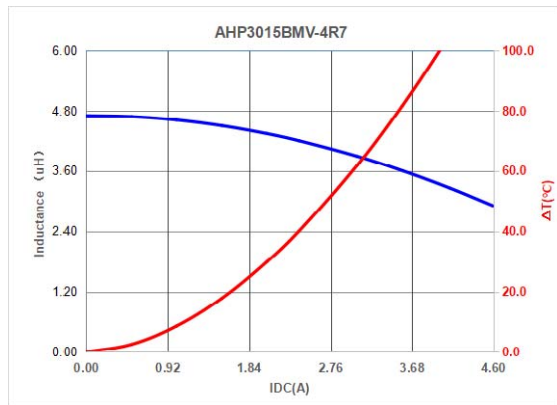
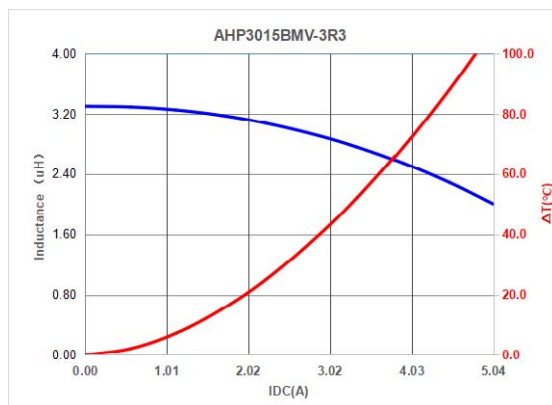
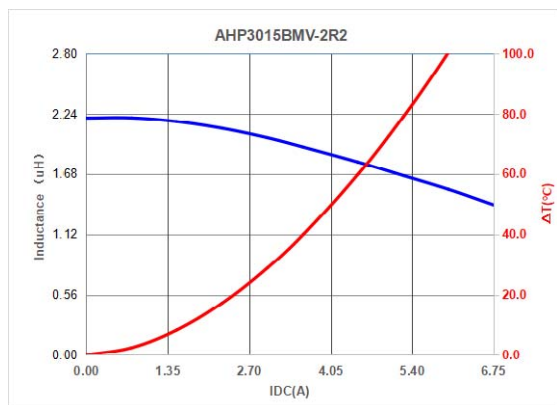
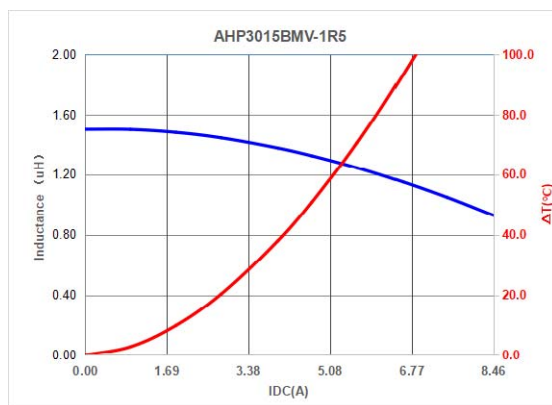
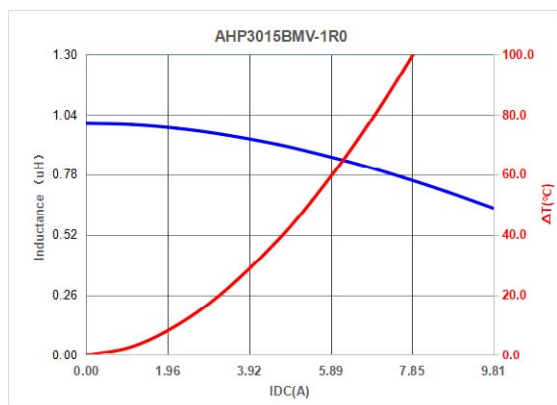
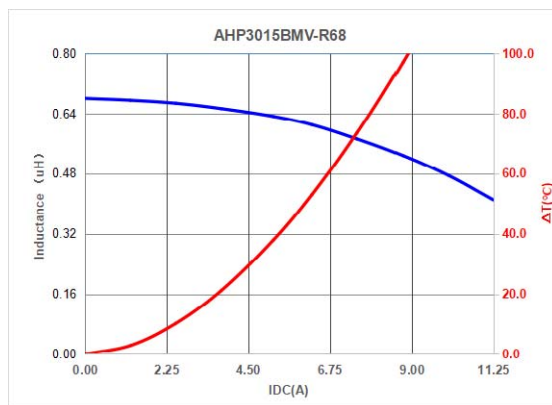
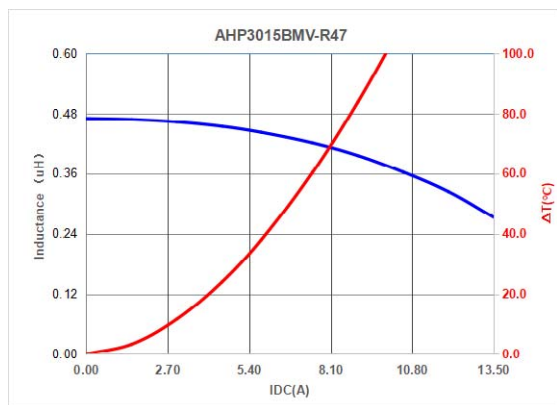
5、Specification

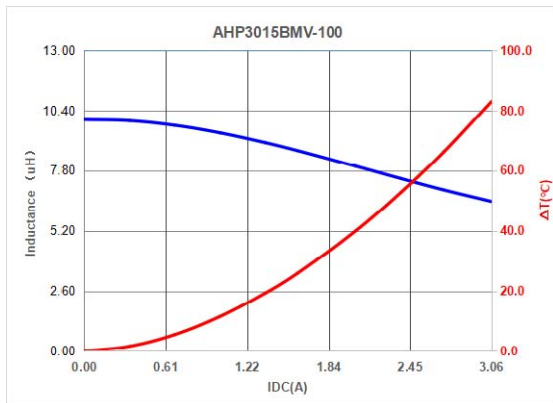
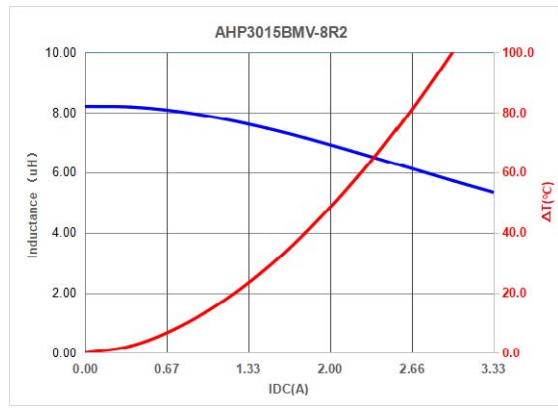
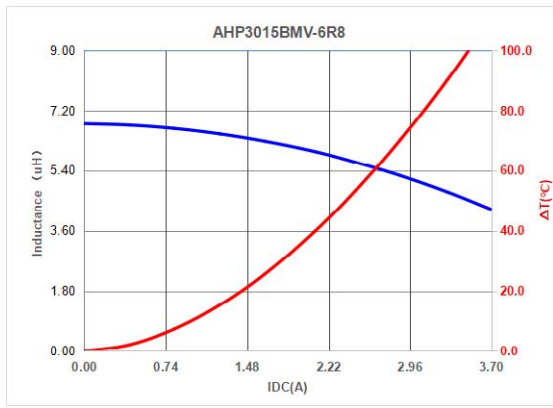
TAI-TECH Part Number	Inductance (uH)	I rms (A)		I sat (A)		DCR (m Ω)	
		typ	Max	typ	Max	typ	Max
AHP3015BMV-R47M	0.47	5.80	5.10	12.00	10.00	25	30
AHP3015BMV-R68M	0.68	5.20	4.70	10.00	9.00	32	38.4
AHP3015BMV-1R0M	1.00	4.60	4.00	8.70	7.80	42	50.4
AHP3015BMV-1R5M	1.50	4.00	3.60	7.50	6.90	55	66
AHP3015BMV-2R2M	2.20	3.60	3.10	6.00	5.50	68	81.6
AHP3015BMV-3R3M	3.30	2.90	2.60	4.50	4.20	116	140
AHP3015BMV-4R7M	4.70	2.40	2.10	4.10	3.90	159	190
AHP3015BMV-5R6M	5.60	2.20	1.90	3.70	3.30	200	240
AHP3015BMV-6R8M	6.80	2.10	1.80	3.30	2.90	210	260
AHP3015BMV-8R2M	8.20	1.80	1.50	3.00	2.60	300	360
AHP3015BMV-100M	10.0	1.60	1.30	2.70	2.30	370	444

Note:

1. Test frequency : L_s : 1MHz /1.0V.
2. All test data referenced to 25°C ambient.
3. Testing Instrument(or equ) : Agilent 4284A,E4991A,4339B,KEYSIGHT E4980A/AL,chroma3302,3250,16502.
4. Heat Rated Current (I rms) will cause the coil temperature rise approximately ΔT of 40°C
5. Saturation Current (Isat) will cause L0 to drop approximately 30%.
6. The part temperature (ambient + temp rise) should not exceed 125°C under worst case operating conditions.Circuit design,component,PCB trace size and thickness,airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.
7. I rms Testing : Temperature rise is highly dependent on many factors including pcb land pattern, trace size, and proximity to other components.
Therefore temperature rise should be verified in application conditions.
8. Rated DC current: The lower value of I rms and Isat.

11、Typical Performance Curves





单击下面可查看定价，库存，交付和生命周期等信息

[>>TAI-TECH\(台庆\)](#)